

**100V N-CHANNEL ENHANCEMENT MODE MOSFET**

**MAIN CHARACTERISTICS**

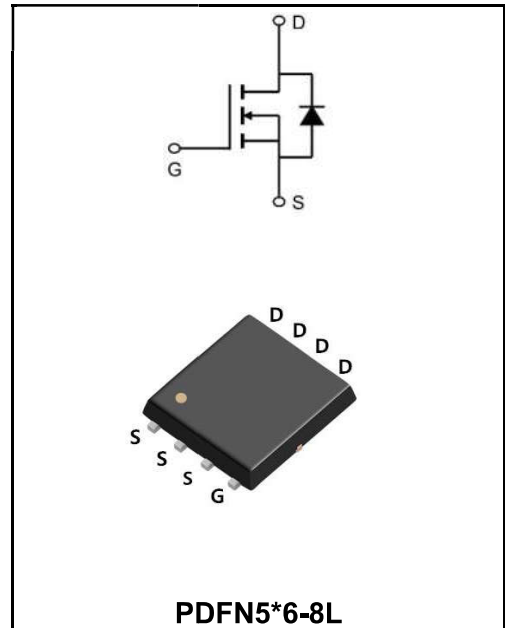
<b>I<sub>D</sub></b>	120A
<b>V<sub>DSS</sub></b>	100V
<b>R<sub>DS(on)-typ(@V<sub>GS</sub>=10V)</sub></b>	< 4.5mΩ ( <b>Type:3.8 mΩ</b> )

**Features**

◆ **YFW-SGT technology**

**Application**

- ◆ Isolated DC
- ◆ Motor control
- ◆ Synchronous-rectification



**Product Specification Classification**

Part Number	Package	Marking	Pack
YFW120N10NF	PDFN5*6-8L	YFW 120N10NF XXXXX	5000PCS/Tape

**Maximum Ratings at T<sub>c</sub>=25°C unless otherwise specified**

Characteristics	Symbols	Value	Units
Drain-Source Voltage	<b>V<sub>DS</sub></b>	100	<b>V</b>
Gate - Source Voltage	<b>V<sub>GS</sub></b>	±20	<b>V</b>
Continuous Drain Current <sup>1</sup> @T <sub>A</sub> =25°C	<b>I<sub>D</sub></b>	120	<b>A</b>
Continuous Drain Current <sup>1</sup> @T <sub>A</sub> =70°C	<b>I<sub>D</sub></b>	76	<b>A</b>
Pulsed Drain Current <sup>2</sup>	<b>I<sub>DM</sub></b>	480	<b>A</b>
Single Pulse Avalanche Energy <sup>3</sup>	<b>E<sub>AS</sub></b>	320	<b>mJ</b>
Avalanche Current	<b>I<sub>AS</sub></b>	40	<b>A</b>
Total Power Dissipation <sup>4</sup> @T <sub>A</sub> =25°C	<b>P<sub>D</sub></b>	131.6	<b>W</b>
Storage Temperature Range	<b>T<sub>STG</sub></b>	-55 to +150	<b>°C</b>
Operating Junction Temperature Range	<b>T<sub>J</sub></b>	-55 to +150	<b>°C</b>
Thermal Resistance, Junction ambient <sup>1</sup>	<b>R<sub>θJA</sub></b>	25	<b>°C/W</b>
Thermal Resistance, Junction-case <sup>1</sup>	<b>R<sub>θJC</sub></b>	0.95	<b>°C/W</b>

**Maximum Ratings at Tc=25°C unless otherwise specified**

Characteristics	Test Condition	Symbols	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	<b>V(BR)DSS</b>	100	107	-	<b>V</b>
Gate Body Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	<b>I<sub>GSS</sub></b>	-	-	$\pm 100$	<b>nA</b>
Zero Gate Voltage Drain Current	$V_{DS}=100V, V_{GS}=0V, T_J=25^\circ C$	<b>I<sub>DSS</sub></b>	-	-	1	<b><math>\mu A</math></b>
	$V_{DS}=100V, V_{GS}=0V, T_J=100^\circ C$		-	-	100	
Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	<b>V<sub>GS(th)</sub></b>	2.0	3.0	4.0	<b>V</b>
Drain-Source on-Resistance <sup>4</sup>	$V_{GS}=10V, I_D=20A$	<b>R<sub>DS(ON)</sub></b>	-	3.8	4.5	<b>m<math>\Omega</math></b>
Forward Transconductance <sup>4</sup>	$V_{DS}=10V, I_D=20A$	<b>g<sub>fs</sub></b>	-	62	-	<b>S</b>
Input Capacitance	$V_{DS}=50V$ $V_{GS}=0V$ $f=1MHz$	<b>C<sub>iss</sub></b>	-	6865	-	<b>pF</b>
Output Capacitance		<b>C<sub>oss</sub></b>	-	740	-	
Reverse Transfer Capacitance		<b>C<sub>rss</sub></b>	-	21	-	
Gate Resistance	$f=1MHz$	<b>R<sub>g</sub></b>	-	1.3	-	<b><math>\Omega</math></b>
Total Gate Charge	$V_{GS}=10V$ $V_{DS}=50V$ $I_D=20A$	<b>Q<sub>g</sub></b>	-	111.2	-	<b>nC</b>
Gate-Source Charge		<b>Q<sub>gs</sub></b>	-	30.5	-	
Gate-Drain Charge		<b>Q<sub>gd</sub></b>	-	27.3	-	
Turn-on delay time	$V_{GS}=10V$ $V_{DD}=50V$ $R_G=3\Omega$ $I_D=20A$	<b>t<sub>d(on)</sub></b>	-	33	-	<b>ns</b>
Rise Time		<b>T<sub>r</sub></b>	-	39	-	
Turn-Off Delay Time		<b>t<sub>d(OFF)</sub></b>	-	67.1	-	
Fall Time		<b>t<sub>f</sub></b>	-	32	-	
Body Diode Reverse Recovery Time	$I_F=20A, dI/dt=100A/\mu s$	<b>t<sub>rr</sub></b>	-	58.7	-	<b>ns</b>
Body Diode Reverse Recovery Charge		<b>Q<sub>rr</sub></b>	-	97.3	-	<b>nC</b>
Diode Forward Voltage <sup>4</sup>	$V_{GS}=0V, I_S=20A$	<b>V<sub>SD</sub></b>	-	-	1.2	<b>V</b>
Continuous Source Current T <sub>C</sub> =25°C		<b>I<sub>S</sub></b>	-	-	120	<b>A</b>

Note :

- 1、 The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$
- 3、 The EAS data shows Max. rating . The test condition is  $V_{DD}=72V, V_{GS}=10V, L=0.1mH, I_{AS}=40A$
- 4、 The power dissipation is limited by 150°C junction temperature
- 5、 The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub> , in real applications , should be limited by total power dissipation

Ratings and Characteristic Curves

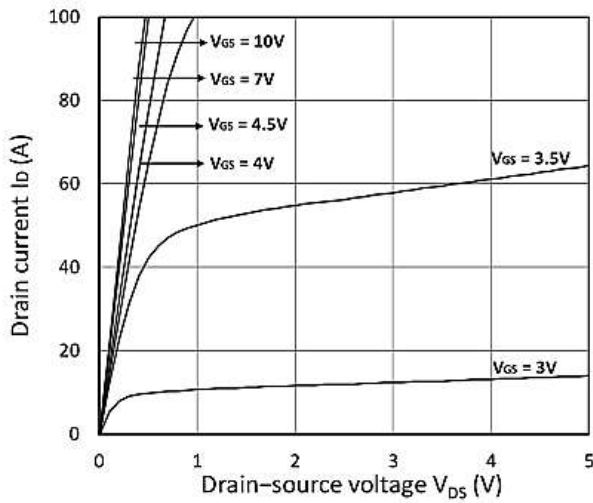


Figure 1. Output Characteristics

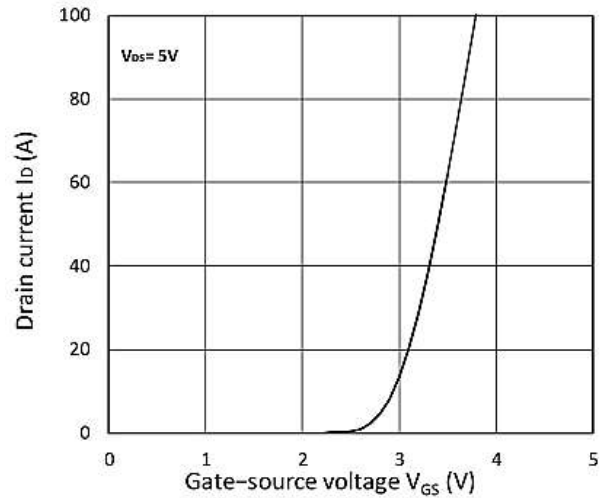


Figure 2. Transfer Characteristics

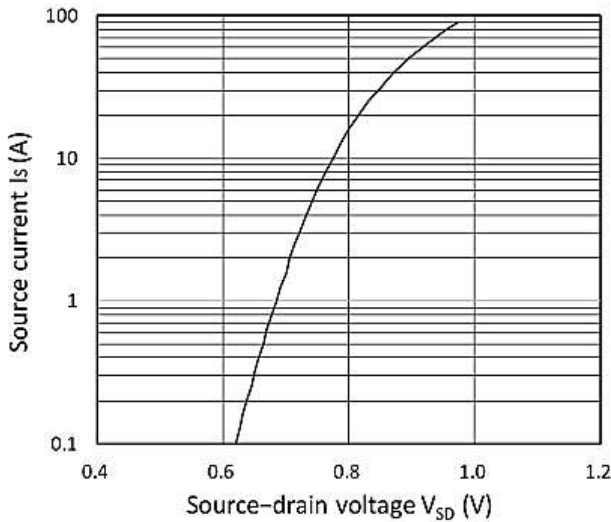


Figure 3. Forward Characteristics of Reverse

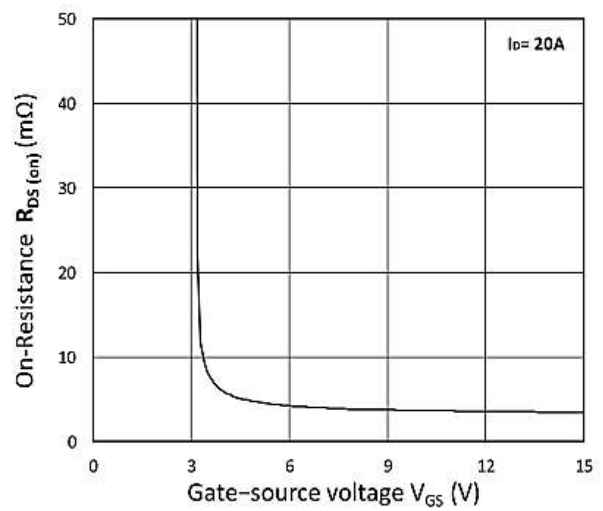


Figure 4. RDS(ON) vs. VGS

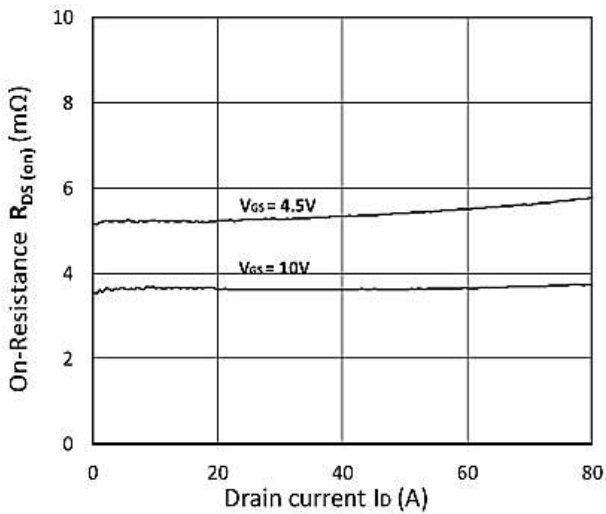


Figure 5. RDS(ON) vs. ID

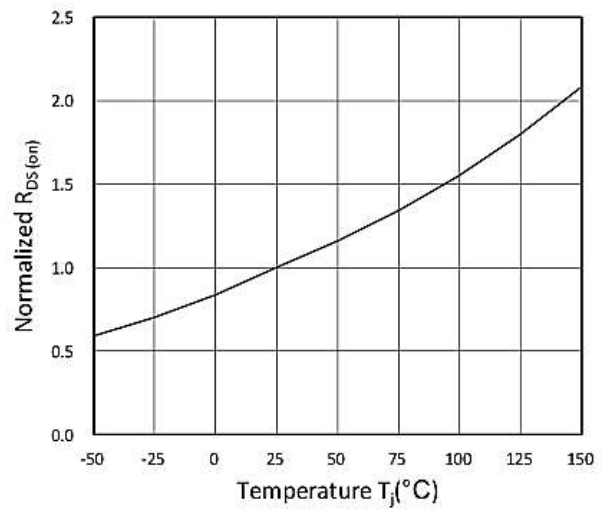


Figure 6. Normalized RDS(on) vs. Temperature

Ratings and Characteristic Curves

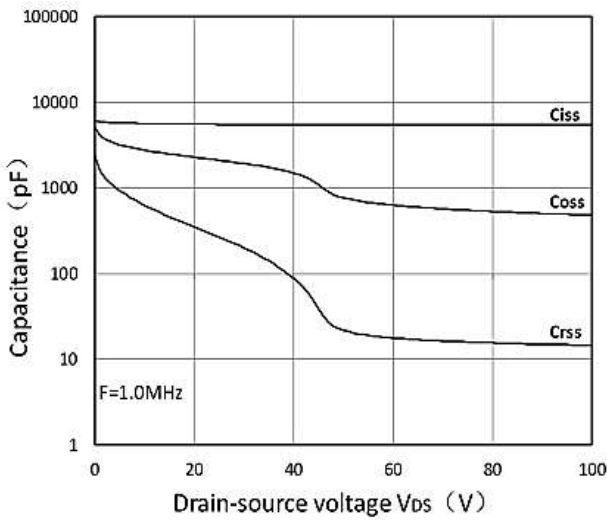


Figure 7. Capacitance Characteristics

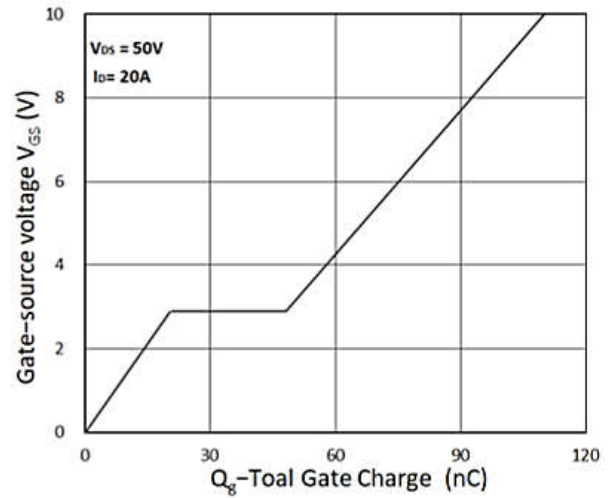


Figure 8. Gate Charge Characteristics

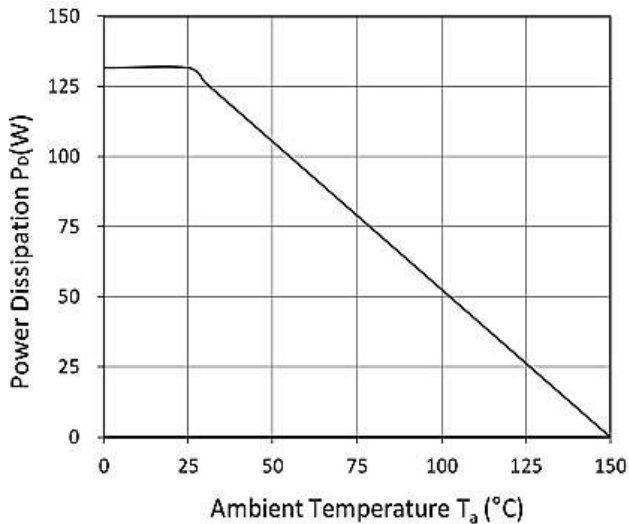


Figure 9. Power Dissipation

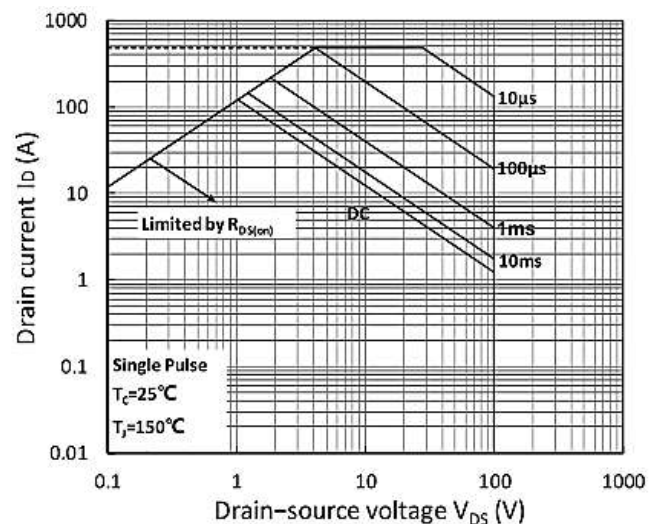


Figure 10. Safe Operating Area

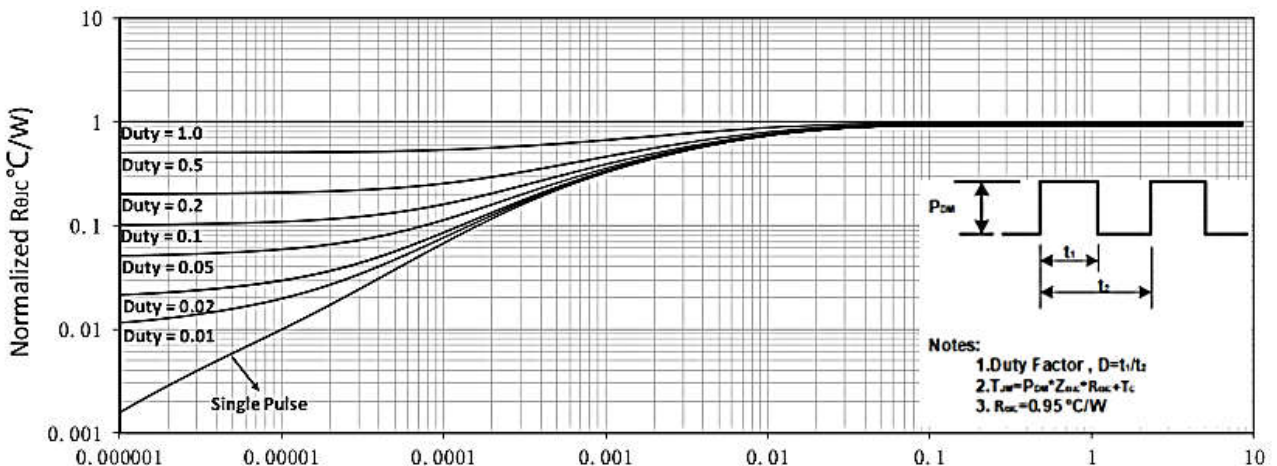
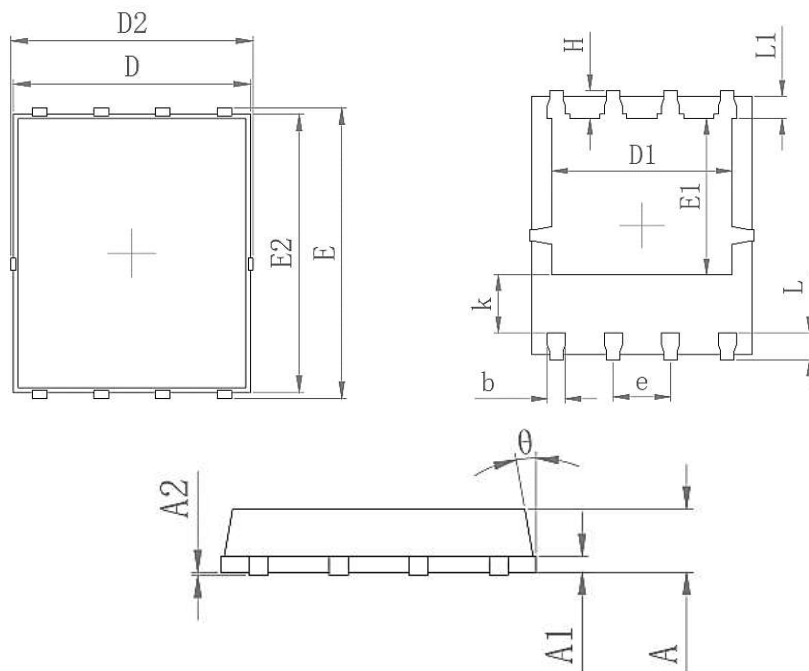


Figure 11. Normalized Maximum Transient Thermal Impedance

PDFN5X6-8L



Symbol	Common	
	mm	
	Mim	Max
A	0.90	1.10
A1	0.254 REF	
A2	0-0.05	
D	4.824	4.976
D1	3.910	4.110
D2	4.944	5.076
E	5.924	6.076
E1	3.375	3.575
E2	5.674	5.826
b	0.350	0.450
e	1.270	
L	0.534	0.686
L1	0.424	0.576
K	1.190	1.390
H	0.549	0.701
$\Phi$	8°	12°